

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
		Examiner Hoai V Pham	Art Unit 2814	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-	US-6,570,237	05-2003	Kitamura, Akio	257/499
B	US-				
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D	US-				
E	US-				
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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